

Image-Force Barrier Lowering of Contact Resistance for Two-Dimensional Materials:

Direct Determination and Method of Images on a Cone Manifold

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Introduction

- 2D Materials
 - TMD as channel material
- Limited by high:
 - Schottky barriers
 - Contact Resistance (R_C)



[1] Y. Liu, et al., "Promises and prospects of two-dimensional transistors," Nature, 2021

Image Force Barrier Lowering (IFBL)



[2] Baliga, B.J., *Springer* (2019).



How can we solve for IFBL?

• Method of Images!

For asymmetrical geometry?

- Method of images
- Poisson's equation





The Problem:

- IFBL necessary to find R_C
- No solution for geometries like (b)



Isolating The Image Potential (V_I)



[3] S. Evans, *et al.*, "Image-Force Barrier Lowering for Two-Dimensional Materials: Direct Determination and Method of Images on a Cone Manifold," arXiv, 2023

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Determining U_{IFBL} from V_{I}

To find U_{IFBL} , we solve:

$$U_{\rm IFBL}(r,\theta) = -\int_{0}^{-e} \frac{q}{e} V_{\rm I}(r_0,\theta_0,z_0;r,\theta,z) dq = -\frac{1}{2} e V_{\rm I}$$

Found from
 $V_{\rm I} = V - V_{\rm C}$



q = charge of electron e = charge of the electron inducing U_{IFBL}

Isolating V_I

- Find V with Poisson's Equation: $V(r,\theta,z) = \frac{e}{\varepsilon} \int_0^\infty dk_z Z_{k_z}(z) \int_0^\infty d\alpha C_{\alpha,k_z} \Theta_\alpha(\theta) R_{\alpha k_z}(r)$
 - Solve Θ(θ) with 2 sets of boundary conditions:
 - 1. Point charge in free space (V_c) 2. Point charge near a metal wedge (V) $\Theta_{;\alpha}(\theta;\theta_0) = \frac{\sinh(\alpha\theta)\cosh\left(\alpha(\pi - (\Omega - \theta_0))\right)}{\alpha\sinh(\alpha\pi)\sinh(\alpha\Omega)}$ $\Theta_{\mathrm{C};\alpha}(\theta;\theta_0) = -\frac{\cosh(\alpha(\pi - |\theta - \theta_0|))}{\alpha\sinh(\alpha\pi)}$ $h(\alpha(\Omega - \theta)) \cosh(\alpha(\pi - \theta_0))$ -3 - 0.1864 - 0.1864 0.0378-0.1712 $-0.1560 \ge$ $-0.1408 \ge$ - 0.1712 -2 -2 $\alpha \sinh(\alpha \pi) \sinh(\alpha \Omega)$ 0.0747 $\frac{0.1560}{0.1408}$ -1 (uu) *h* 0.1408 -1 0.1408 (nm)0.1256 0 0.1104 च -0.2224 $\stackrel{\text{lab}}{\rightarrow}$ -0.2593 $\stackrel{\text{lab}}{\rightarrow}$ З 0.0952 5 $\alpha \sinh(\alpha \pi)$ 0.0800 0.0800 -0.29630.0648 -0.33320.0648 0.0496 0.0496-0.00083 2 1 0 -1 -2 -3 0 -1 -2 -3 3 2-0.0378x (nm)x (nm)-0.0747-0.1116 > .1 -0.1485 $\overrightarrow{\text{re}}$ -0.1855 $\overrightarrow{\text{re}}$ (un -0.22-0.25-0.290.333 2 1 0 -1 -2 -3 2 1 0 -1 -2 -3 x (nm)x (nm)

Ζμ

Results: IFBL Potential Energy



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Method of Images on a Cone Manifold

Previously I said that I can not solve asymmetrical problems using method of images...



Method of Images on a Cone Manifold



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Method of Images on a Cone Manifold (cont.)

- We can now **easily place an image charge**, regardless of asymmetrical geometry
- Results are equal through trig identities



$$U_{\text{IFBL}}(r,\theta) = \frac{-e^2}{8\pi\varepsilon r} \int_0^\infty \mathrm{d}\alpha \left(\frac{\cosh(\alpha(\Omega-\eta))\sinh(\alpha\pi)}{\sinh(\alpha\Omega)\cosh(\alpha\pi)} - \frac{\cosh(\alpha(\Omega-2\theta))\sinh(\alpha\pi)}{\sinh(\alpha\Omega)\cosh(\alpha\pi)} - \frac{\cosh(\alpha(\pi-\eta))}{\cosh(\alpha\pi)} \right)$$

$$U_{\text{IFBL}}(r,\theta) = \frac{-e^2}{8\pi\varepsilon r} \left(\int_0^\infty \mathrm{d}\alpha \frac{\sinh(\alpha(\Omega-\pi))}{\sinh(\alpha\Omega)\cosh(\alpha\pi)} + \int_0^\infty \mathrm{d}\alpha \frac{\cosh(\alpha(\Omega-2\theta))\tanh(\alpha\pi)}{\sinh(\alpha\Omega)} \right)$$

Results: U_{IFBI}





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Conclusions

- IFBL necessary for accurate R_c calculation
 - But significantly impacted by contact geometry
- U_{IFBL} determined for asymmetrical geometries:
 - Poisson's equation
 - Cone manifold
- $U_{\rm IFBL} \propto \frac{1}{\epsilon}$
- Contact angle can act as tunable parameter
 - Impacts Schottky barrier and R_c



Thank you!

Please feel free to ask any questions

S. Evans, *et al.*, "Image-Force Barrier Lowering for Two-Dimensional Materials: Direct Determination and Method of Images on a Cone Manifold," arXiv, 2023

Future work



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$$U_{\text{IFBL}}(r,\theta) = -\int_{0}^{-e} \frac{q}{e} V_{\text{I}}(r_{0},\theta_{0},z_{0};r,\theta,z) dq = -\frac{1}{2} eV_{\text{I}} \quad (1) \qquad V_{\text{I}} = \frac{e}{4\pi\epsilon\sqrt{rr_{0}}} \int_{0}^{\infty} d\alpha P_{i\alpha-1/2} \left(\frac{(z-z_{0})^{2}+r_{0}^{2}+r^{2}}{2rr_{0}}\right) \quad (4)$$

$$\Theta_{\text{I};\alpha}(\theta;\theta_{0}) = \frac{\sinh(\alpha\theta)\cosh\left(\alpha(\pi-(\Omega-\theta_{0}))\right)}{\alpha\sinh(\alpha\pi)\sinh(\alpha\Omega)} \quad (2) \qquad \left(\frac{\sinh(\alpha\theta)\cosh\left(\alpha(\pi-(\Omega-\theta_{0}))\right)}{\sinh(\alpha\Omega)\cosh(\alpha\pi)}\right)$$

$$+\frac{\sinh(\alpha(\Omega-\theta))\cosh\left(\alpha(\pi-\theta_{0})\right)}{\alpha\sinh(\alpha\pi)\cosh(\alpha\pi)} \quad (3) \qquad \Theta_{\text{C};\alpha}^{*}(\theta;\theta_{0}) = -\frac{\cosh(\alpha(\Omega-|\theta-\theta_{0}|))}{\alpha\sinh(\alpha\Omega)} \quad (6)$$

$$U_{\text{IFBL}}(r,\theta) = \frac{-e^{2}}{8\pi\epsilon r} \int_{0}^{\infty} d\alpha \left(\frac{\sinh(\alpha\theta)\cosh(\alpha(\pi-(\Omega-\theta)))}{\sinh(\alpha\Omega)\cosh(\alpha\pi)} + \frac{\sinh(\alpha(\Omega-\theta))\cosh(\alpha(\pi-\theta))}{\sinh(\alpha\Omega)\cosh(\alpha\pi)}\right) \quad (5)$$

$$U_{\text{IFBL}}(r,\theta) = \frac{-e^{2}}{8\pi\epsilon r} \int_{0}^{\infty} d\alpha \frac{\cosh(\alpha(\Omega-2\theta))\sinh(\alpha\pi) + \sinh(\alpha(\Omega-\pi))}{\sinh(\alpha\Omega)\cosh(\alpha\pi)} \quad (7)$$

 $\sinh(\alpha\Omega)\cosh(\alpha\pi)$

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